SEMiX171KH16s

SEMiX® 1s

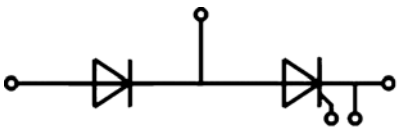
Rectifier Thyr./Diode Module
SEMiX171KH16s

Features

- Terminal height 17 mm
- Chips soldered directly to insulated substrate

Typical Applications*

- Input Bridge Rectifier for AC/DC motor control
- Power supply



KH

Absolute Maximum Ratings				
Symbol	**Conditions**		**Values**	**Unit**
Chip				
$I_{T(AV)}$	sinus 180°	T_c = 85 °C	170	A
		T_c = 100 °C	125	A
I_{TRMS}				A
I_{TSM}	10 ms	T_j = 25 °C	5400	A
		T_j = 130 °C	4800	A
i^2t	10 ms	T_j = 25 °C	145000	A^2s
		T_j = 130 °C	115000	A^2s
V_{RSM}			1700	V
V_{RRM}			1600	V
V_{DRM}			1600	V
$(di/dt)_{cr}$	T_j = 130 °C		200	A/µs
$(dv/dt)_{cr}$	T_j = 130 °C		1000	V/µs
T_j			-40 ... 130	°C
Module				
T_{stg}			-40 ... 125	°C
V_{isol}	AC sinus 50Hz	1 min	4000	V
		1 s	4800	V

Characteristics						
Symbol	**Conditions**		**min.**	**typ.**	**max.**	**Unit**
Chip						
V_T	T_j = 25 °C, I_T = 500 A				1.6	V
$V_{T(TO)}$	T_j = 130 °C				0.85	V
r_T	T_j = 130 °C				1.5	mΩ
I_{DD};I_{RD}	T_j = 130 °C, V_{DD} = V_{DRM}; V_{RD} = V_{RRM}				60	mA
t_{gd}	T_j = 25 °C, I_G = 1 A, di_G/dt = 1 A/µs			1		µs
t_{gr}	V_D = 0.67 * V_{DRM}			2		µs
t_q	T_j = 130 °C			150		µs
I_H	T_j = 25 °C			150	400	mA
I_L	T_j = 25 °C, R_G = 33 Ω			300	1000	mA
V_{GT}	T_j = 25 °C, d.c.		2			V
I_{GT}	T_j = 25 °C, d.c.		150			mA
V_{GD}	T_j = 130 °C, d.c.				0.25	V
I_{GD}	T_j = 130 °C, d.c.				10	mA
$R_{th(j-c)}$	continuous DC	per thyristor				K/W
		per diode				K/W
$R_{th(j-c)}$	sin. 180°	per thyristor			0.18	K/W
		per diode			0.18	K/W
$R_{th(j-c)}$	rec. 120°	per thyristor				K/W
		per diode				K/W
Module						
$R_{th(c-s)}$	per chip					K/W
	per module			0.075		K/W
M_s	to heat sink (M5)		3		5	Nm
M_t	to terminals (M6)		2.5		5	Nm
a					5 * 9,81	m/s^2
w				145		g

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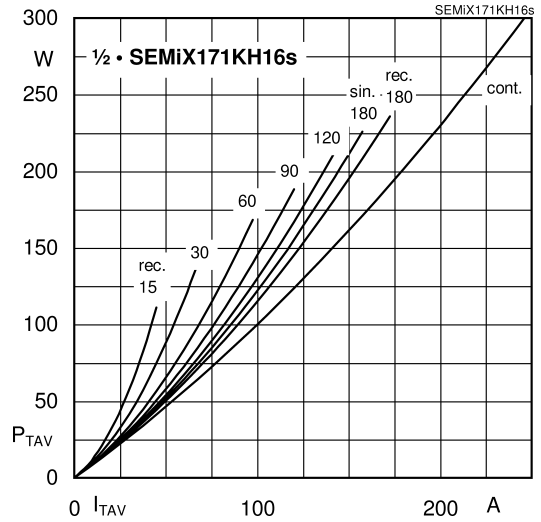

Fig. 1L: Power dissipation per thyristor/diode vs. on-state current

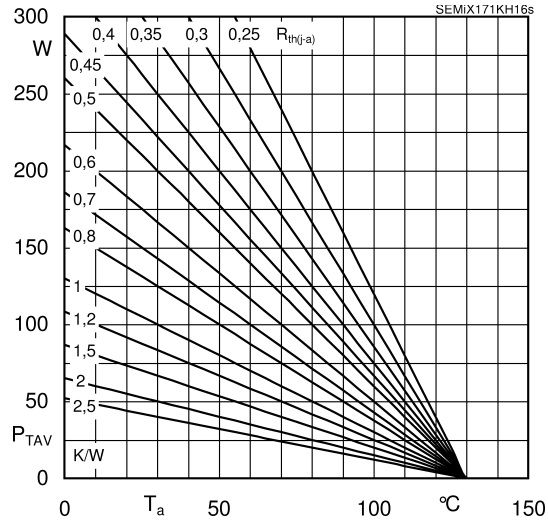

Fig. 1R: Power dissipation per thyristor/diode vs. ambient temperature

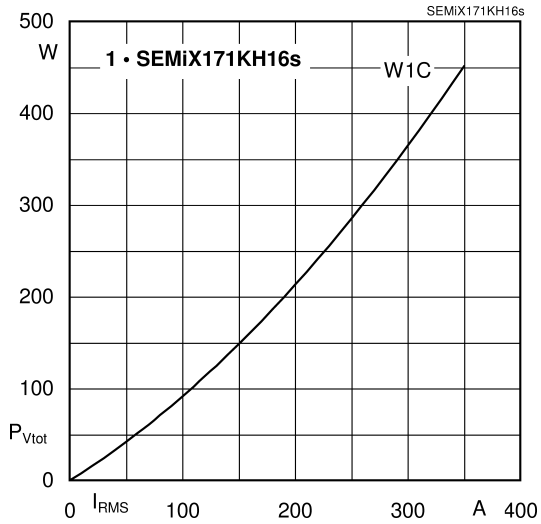

Fig. 2L: Power dissipation of one module vs. rms current

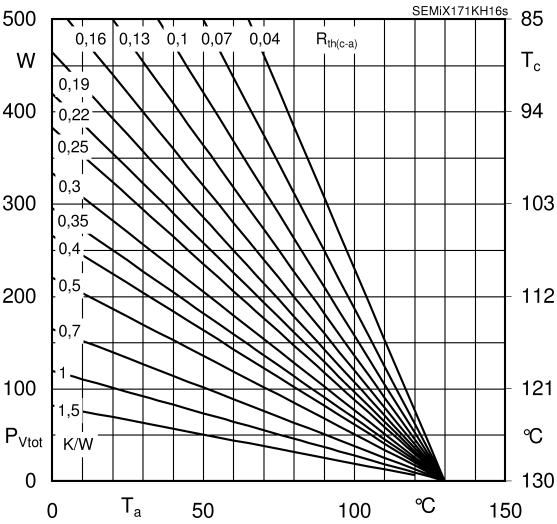

Fig. 2R: Power dissipation of one module vs. case temperature

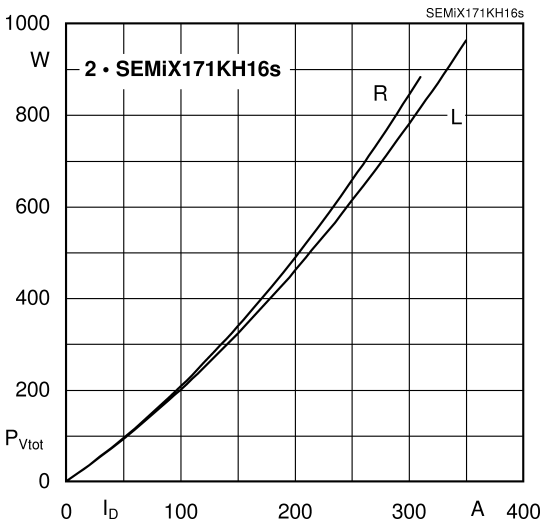

Fig. 3L: Power dissipation of two modules vs. direct current

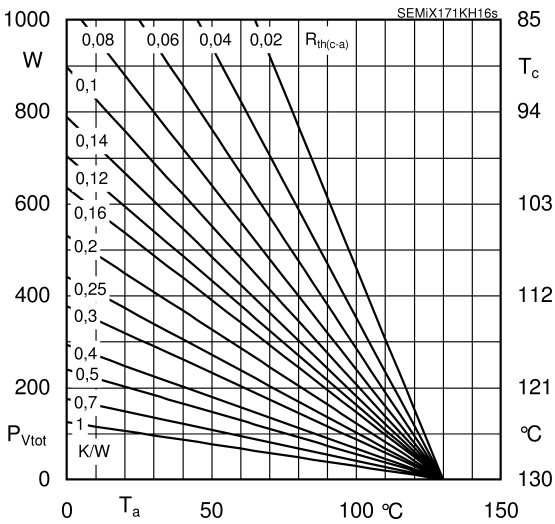

Fig. 3R: Power dissipation of two modules vs. case temperature

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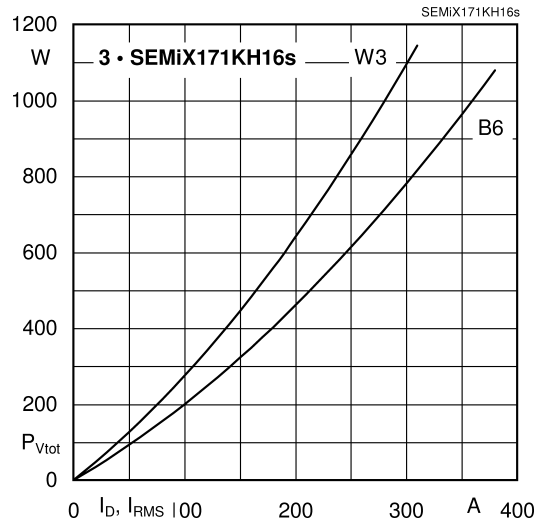

Fig. 4L: Power dissipation of three modules vs. direct current

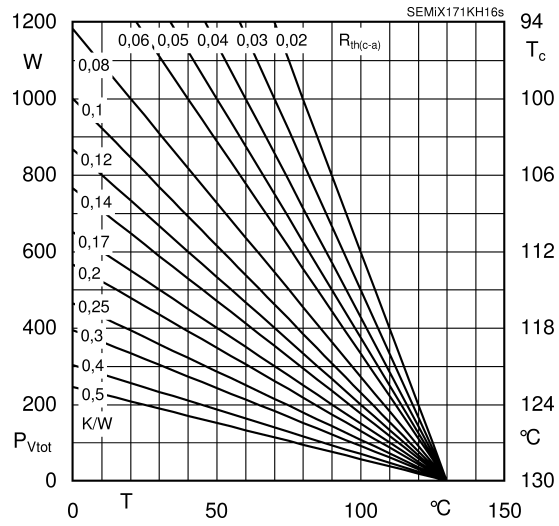

Fig. 4R: Power dissipation of three modules vs. case temperature

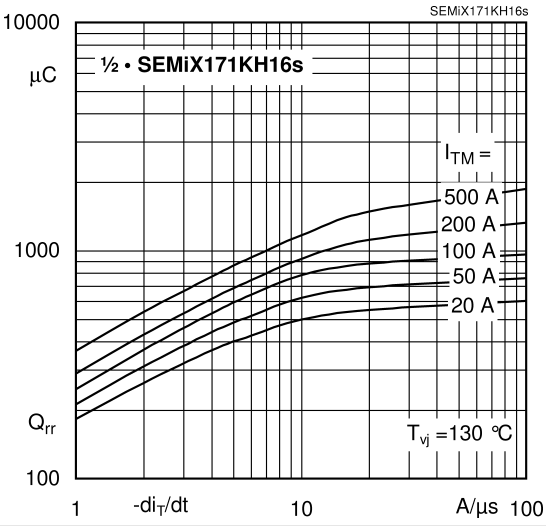

Fig. 5: Recovered charge vs. current decrease

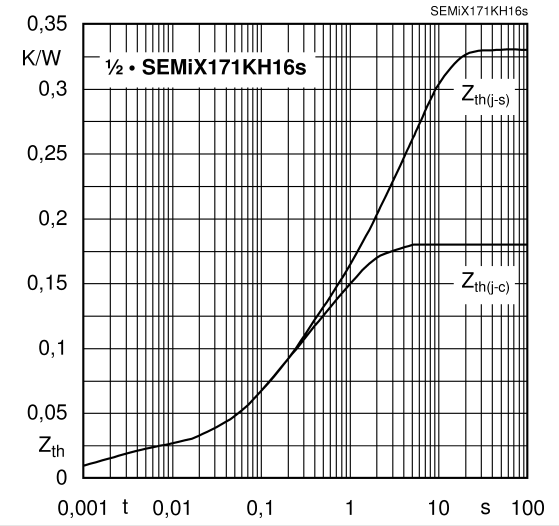

Fig. 6: Transient thermal impedance vs. time

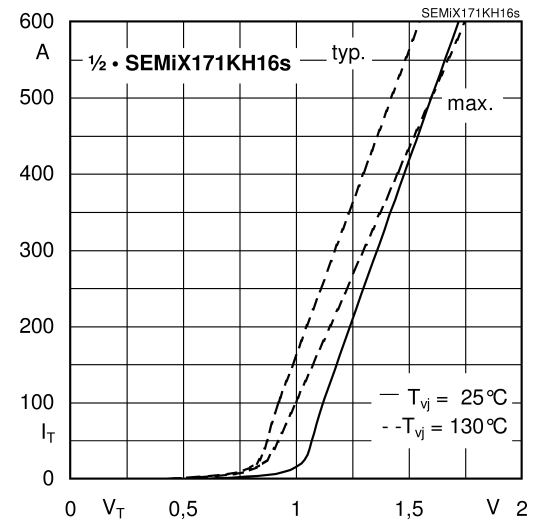

Fig. 7: On-state characteristics

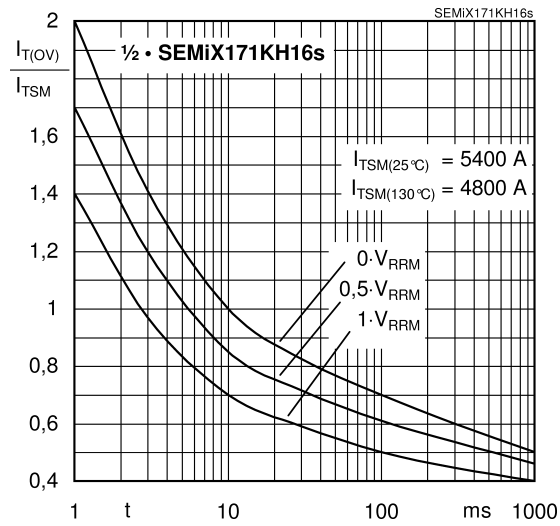

Fig. 8: Surge overload current vs. time

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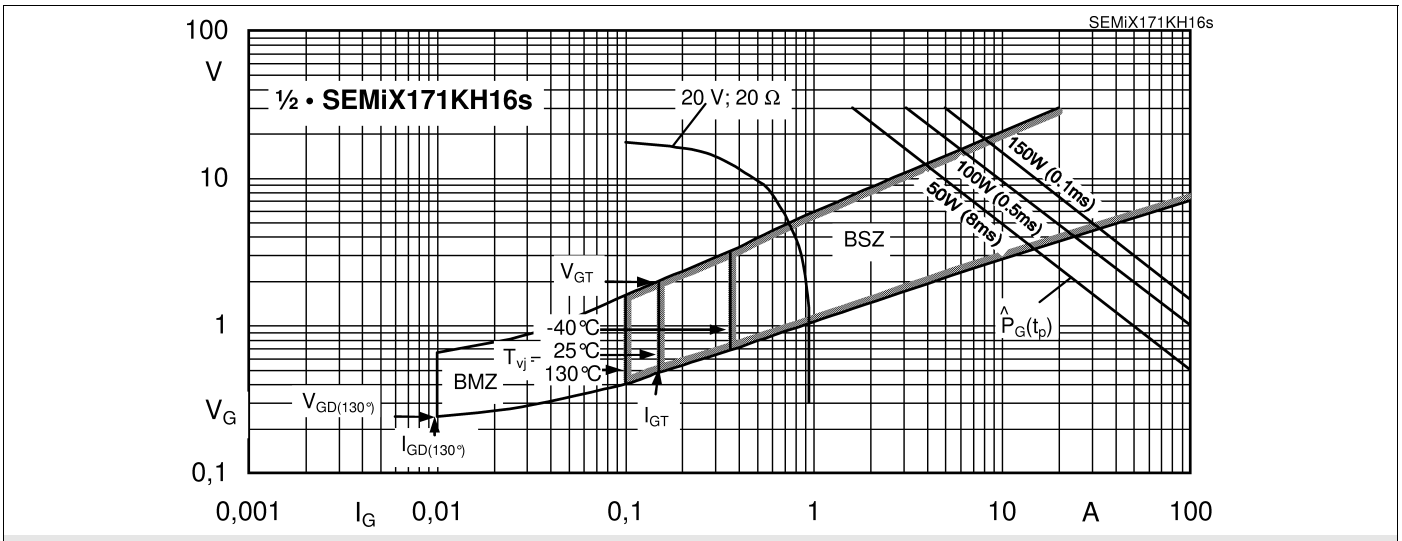
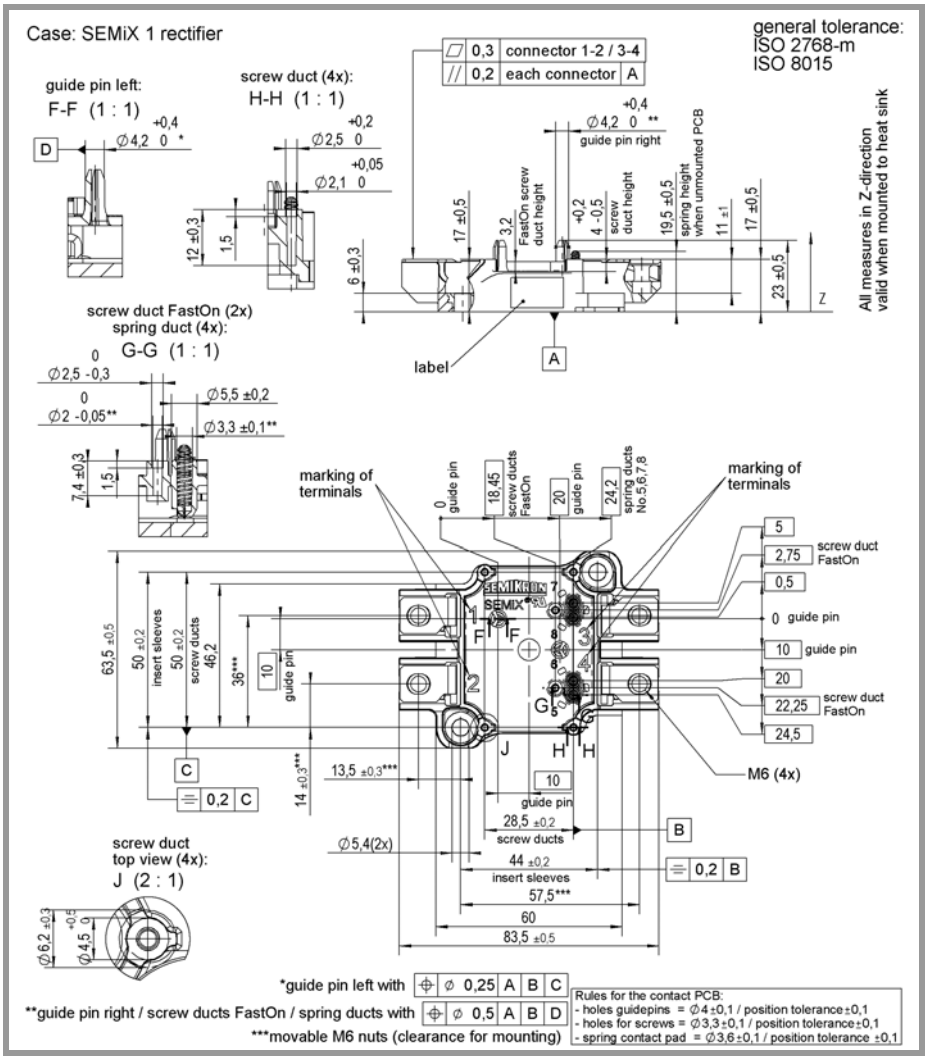


Fig. 9: Gate trigger characteristics



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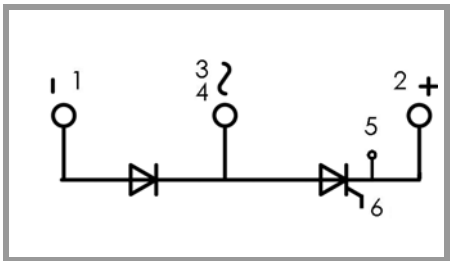

spring configuration

This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX

* The specifications of our components may not be considered as an assurance of component characteristics. Components have to be tested for the respective application. Adjustments may be necessary. The use of SEMIKRON products in life support appliances and systems is subject to prior specification and written approval by SEMIKRON. We therefore strongly recommend prior consultation of our staff.

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